

Notice of References Cited	Application/Control No. 10/676,820		Applicant(s)/Patent Under Reexamination STEINBERG ET AL.	
	Examiner JOHN Wahnkyo LEE		Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,216,504 A	06-1993	Webb et al.	348/190
*	B	US-6,002,436 A	12-1999	Anderson, Eric C.	348/372
*	C	US-2001/0039804 A1	11-2001	Newman et al.	62/66
*	D	US-2002/0093577 A1	07-2002	Kitawaki et al.	348/241
*	E	US-2003/0036860 A1	02-2003	Rice et al.	702/57
*	F	US-2003/0174902 A1	09-2003	Barkan, Stanley	382/274
*	G	US-7,061,648 B2	06-2006	Nakajima et al.	358/1.9
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	03/019473	03-2003	WO	Robins et al.	G06T 5/20
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
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	X				

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